Notice of References Cited Application/Control No. 10/516,742 Examiner Cheung Lee Applicant(s)/Patent Under Reexamination LEE, SUK HUN Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,459,100	10-2002	Doverspike et al.	257/97
*	В	US-2001/0035531	11-2001	Kano et al.	257/96
*	С	US-2002/0125492	09-2002	Shakuda, Yukio	257/94
	D	US-			
	Е	ŅS-			_
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.